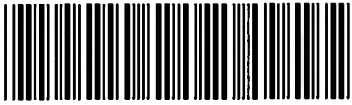


**Search Notes**

Application/Control No.

10/502,390

Examiner

Todd E. Manahan

Applicant(s)/Patent under  
Reexamination

HAYAKAWA ET AL.

Art Unit

3732

**SEARCHED**

Class	Subclass	Date	Examiner
132	112-116	11/28/2006	
401	189		
	148		
222	321.7		
	321.9		
	385		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR